



GEMIMEG Timeline - DCC & DPP in Digital SI-unified Metrology Quality-X

Vom Kalibrierzertifikat zur digitalen Qualitätsinfrastruktur – Ergebnisse aus GEMIMEG-II und anstehende Herausforderungen –

Jena Digital Innovation Hub Opening 2024

Tech:Talk Panel - Impulsvortrag

Dr. Thomas Engel

Jena, 13. August 2024

The GEMIMEG-II Project in a Nutshell



Project start: 01.08.2020
Funding budget: 11,2 M€
Total project budget: 17,9 M€
Project duration: 36 months
Project end: (31.07.2023) → 31.12.2023

Project partners: 13
Industry: 8
NMI: PTB
Applied Research: 1
University: 3

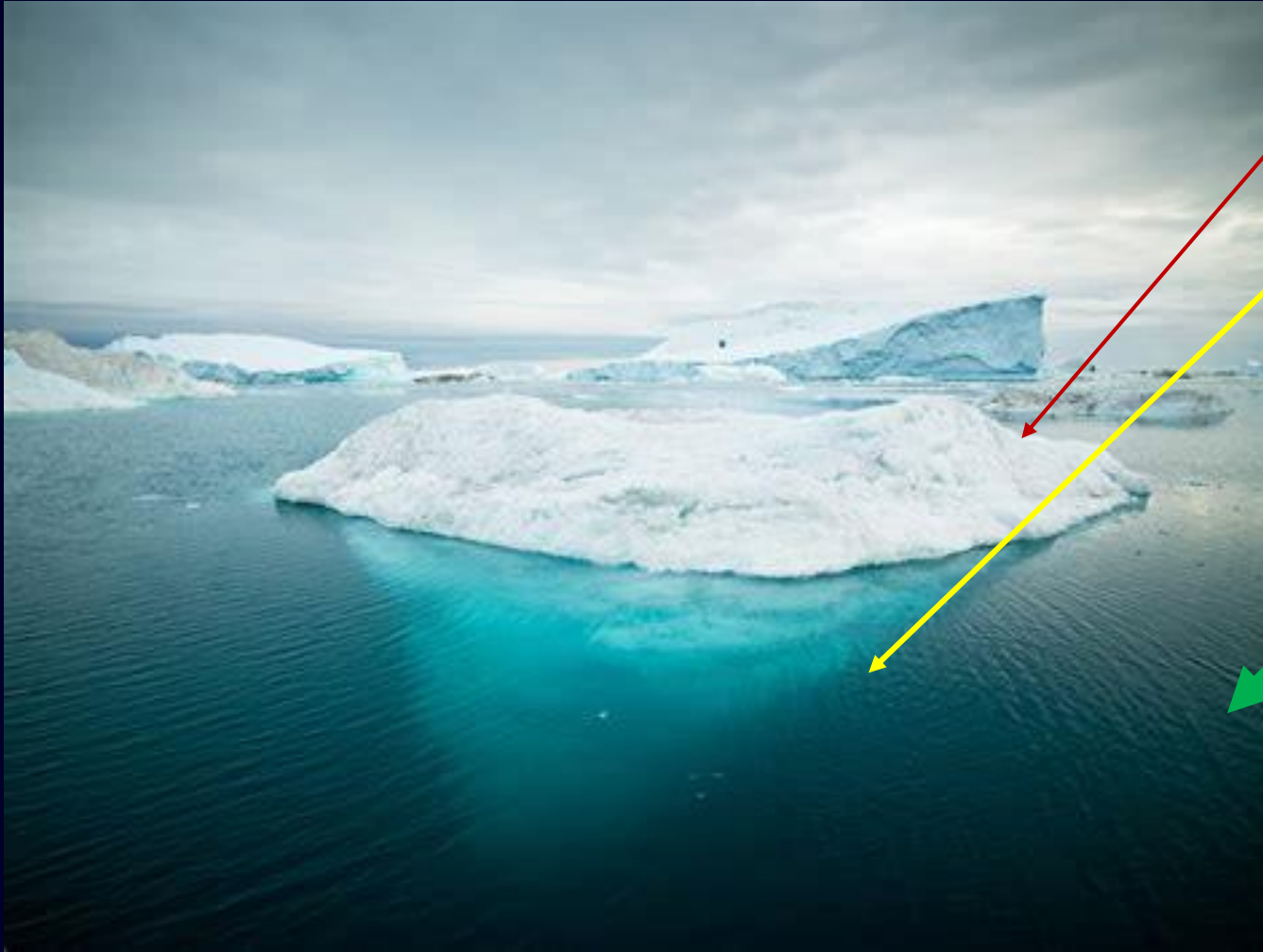
Supported by:



on the basis of a decision
by the German Bundestag



Digitize, Digitalisation and Digital Transformation



Digitize:

- Documents available in digital format

Digitalization:

- Machine readable, machine understandable, machine actionable data / information
 - Related set of (basic) functions
- Semantics, Ontology, Quality information
- Data exchange, interface, platforms

Digital Transformation:

- New business opportunities – cost structure
 - Lower waste / higher first pass yield
 - Higher precision with larger tolerances
- Enabler: more precise data
- Business transformation from „economy of conformity“ to „economy of consistency“

Foto: Alexander Hafemann; Mlenny/iStockphoto.com

Digitize, Digitalisation and Digital Transformation

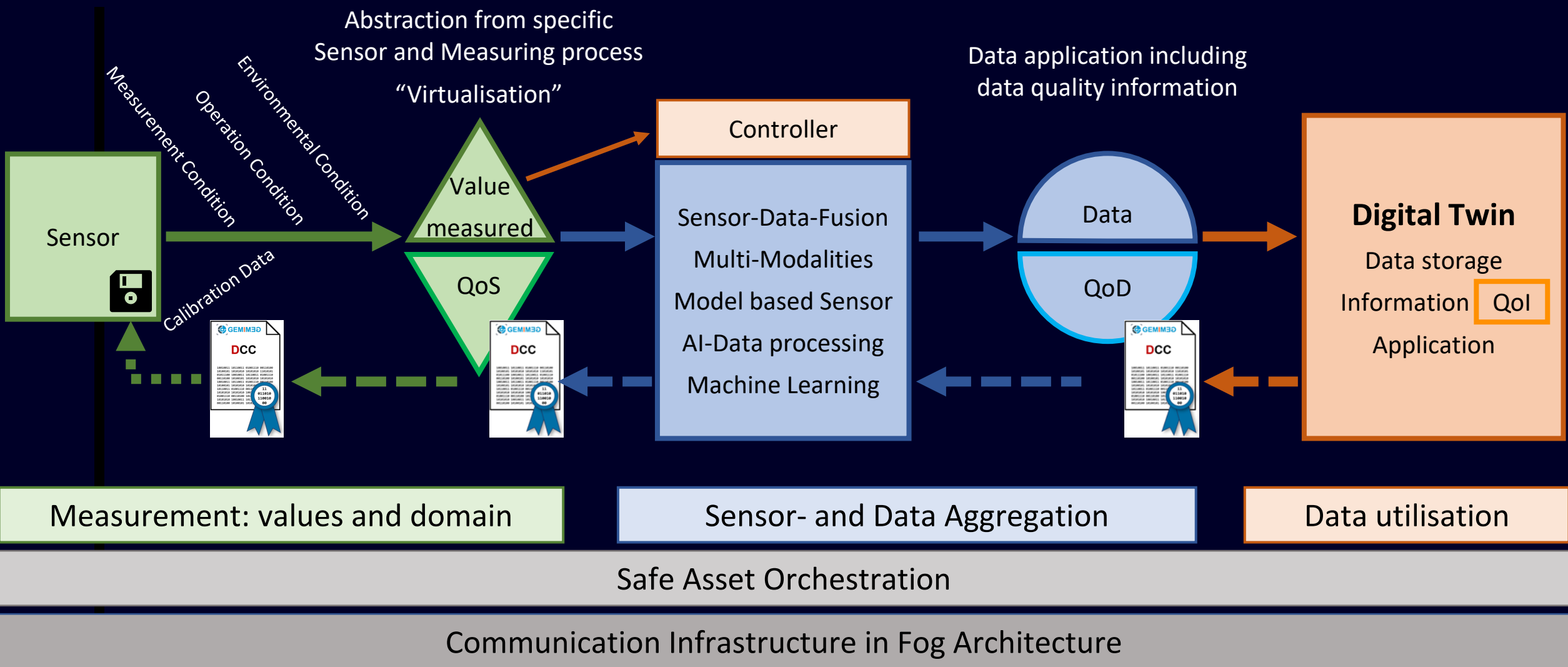
Digitize:

- Documents available in digital format



Foto: Alexander Hafemann; Mlenny/iStockphoto.com

The GEMIMEG - Concept

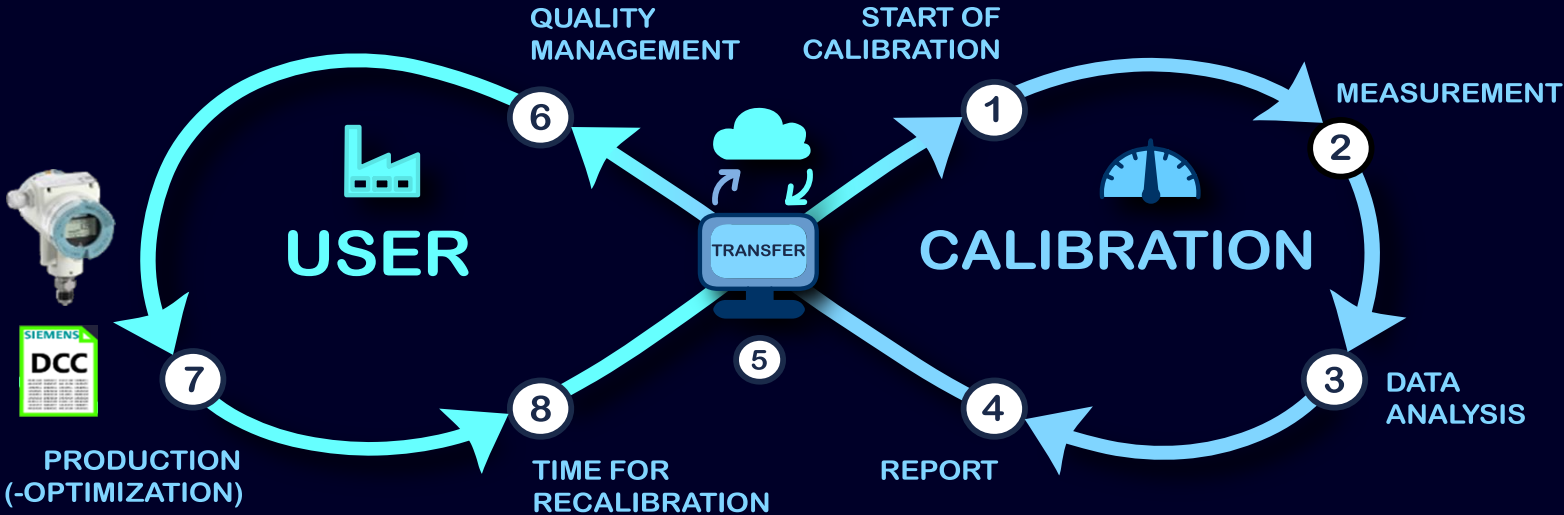


Calibration Usecases

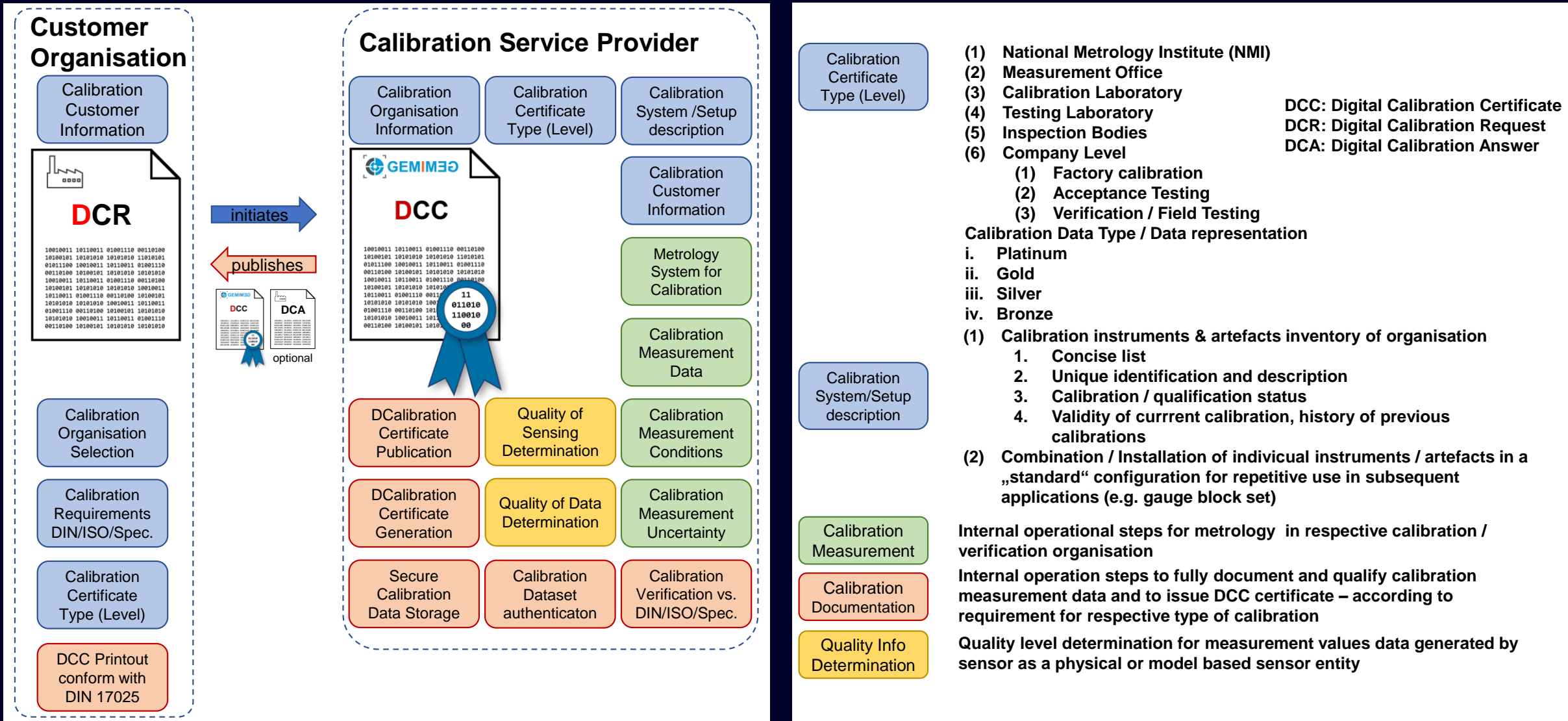
A) Production process



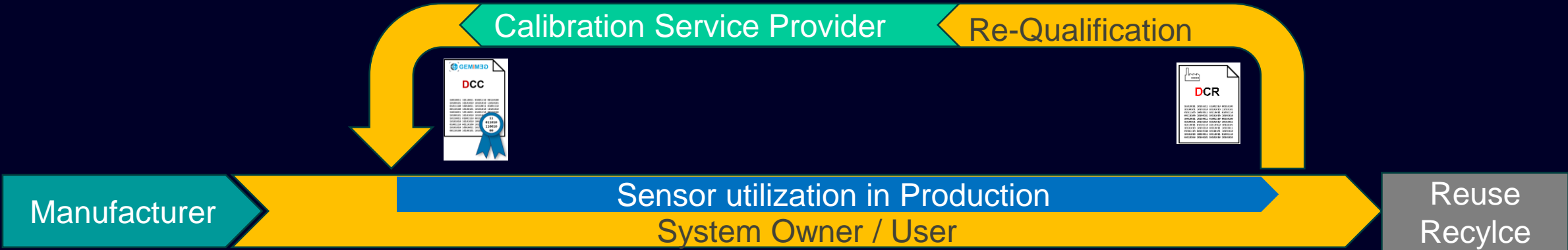
B) Process equipment with periodic recurring calibrations



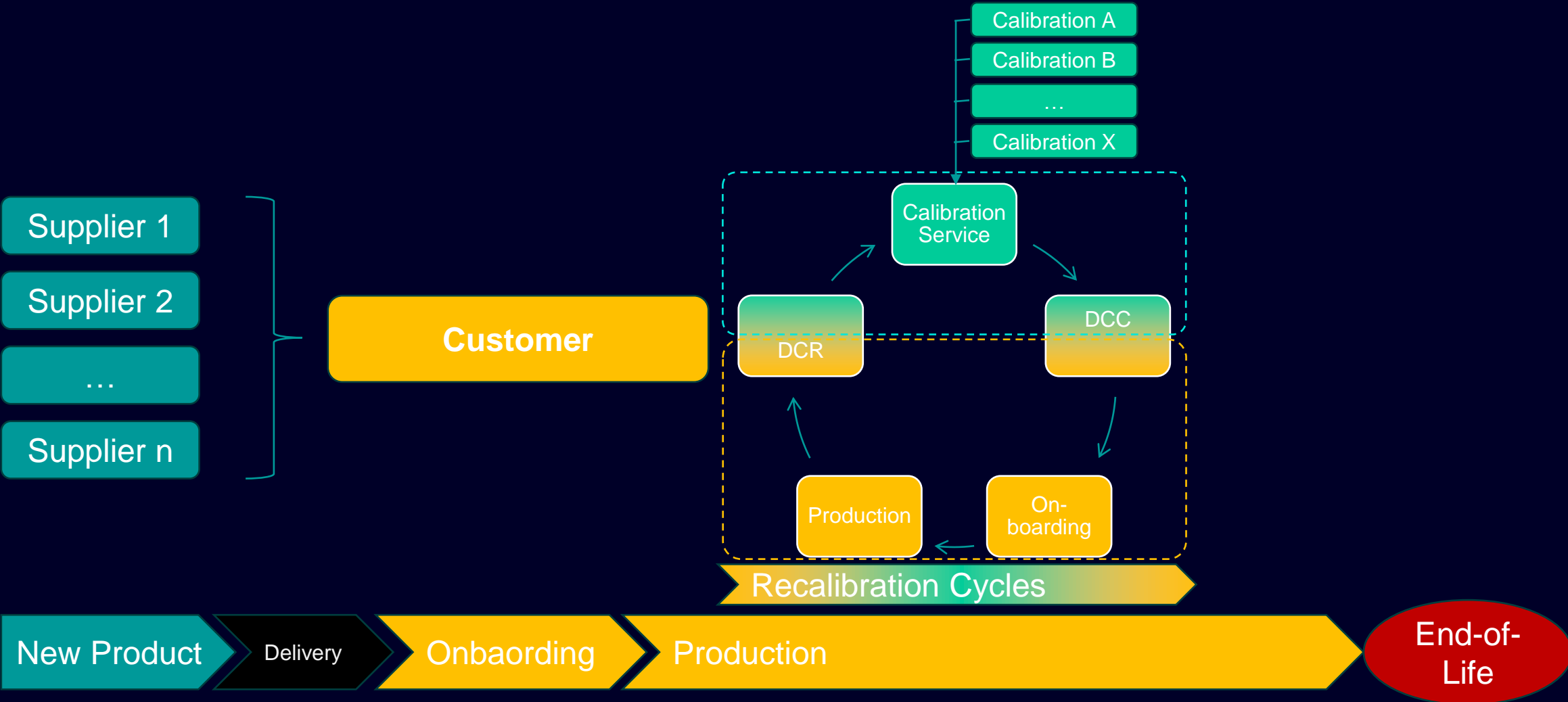
The DCC and its generic components



Productive Lifecycle of a Sensor in Industry



Productive Lifecycle of a Sensor in Industry



Digitize, Digitalisation and Digital Transformation

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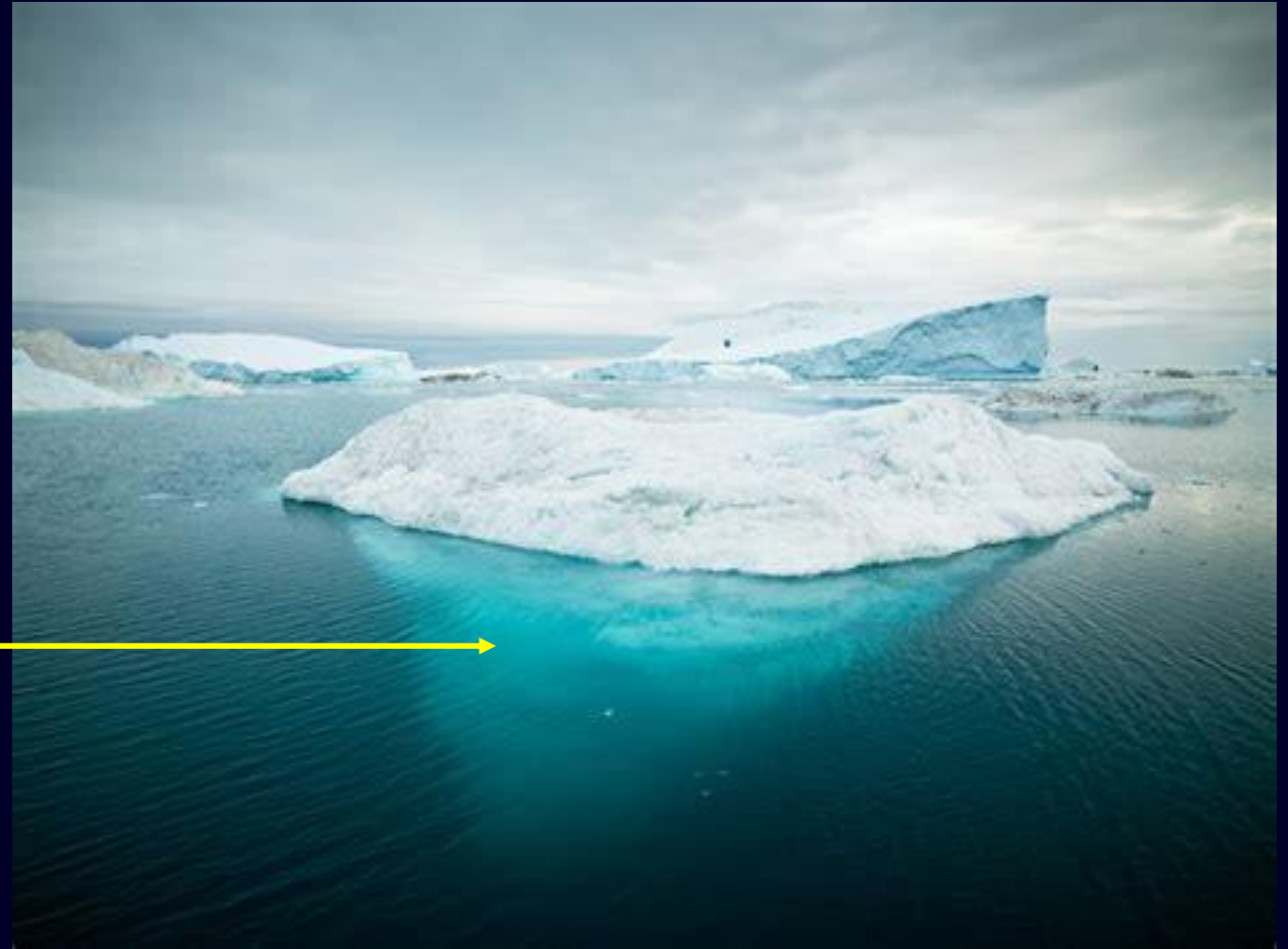


Foto: Alexander Hafemann; Mlenny/iStockphoto.com

Example: Pressure Sensor with 4 – 20 mA Interface

SIEMENS

Certificate / Zertifikat / Certificat
according to / nach / selon EN 10204, Type 3.1

Inspection certificate / Abnahmeprüfzeugnis / Certificat d'inspection

Topic / Thema / Thème :
Quality inspection certificate (Factory calibration) of product SITRANS P (Pressure measurement) /
Qualitätsprüfzertifikat (Werkskalibrierung) von SITRANS P Geräte (Druckmessung) /
Certificat d'inspection qualité (calibrage usine) d'appareil SITRANS P (Transmetteur de pression)

Object / Betreff / Objet :

Customer order / Kundenauftrag / Commande client :
Customer / Kunde / Client :
Internal order / Internauftrag / Commande interne :
Product number / Produktnummer / Produit numéro : 7MF0340
Additional options / Optionen / Options : C11+C12
Product designation / Produktbenennung / Désignation du produit : SITRANS P
Serial number / Seriennummer / Numéro de série : N1N92116

Technical data / Technische Daten / Données techniques :

Certificate option code / Bestellte Zertifikatsoption / Option certifiée commandée : C11
Nominal measuring range / Nennmessbereich / Etendue de mesure : 2,5 ... 250
Max. permissible pressure / Max. Betriebsdruck / Pression admissible max. : PN 160
Output / Ausgang / Sortie : HART 4 ... 20 mA
Selected measuring range / Eingestellter Messbereich / Etendue de mesure paramétrée (Y01)(Y02) : -
Displayed unit / Angezeigte Einheit / Unité (Y21)(Y22)(Y23) : bar
Measuring point number TAG N° / Messstellenbeschreibung / Description du point de mesure (Y15) : -
Measuring point test / Messstellennachricht / Information du point de mesure (Y16) : -
HART Address / HART Adresse / Adresse HART (Y17) : -
PROFIBUS Address / PROFIBUS Adresse / Adresse PROFIBUS (Y25) : -
Damping setting / Dämpfungseinstellung / Valeur d'atténuation (Y32) : 2 s
Fieldbus compatibility / Feldbus Kompatibilität / Compatibilité bus de com (Y26) : -
Saturation limits / Sättigungsgrenzen / Limite de saturation (Y30) : -
Fault current / Fehlerstrom / Courant de défaut (Y31) : -

Standards / Normen / Normes : EN 10204-3.1 + IEC 62828-2

SIEMENS

Certificate / Zertifikat / Certificat
according to / nach / selon EN 10204, Type 3.1

Inspection certificate / Abnahmeprüfzeugnis / Certificat de réception

Results / Ergebnisse / Résultats :

%	Input Pressure (mbar)	Output (mA)		Deviation (%)		Hysteresis (%)
		Up	Down	Up	Down	
0	0,000	3,9995	3,9997	-0,0028	-0,0017	0,0011
25	62,500	8,0004	8,0006	0,0025	0,0035	0,0009
50	125,000	11,9994	11,9999	-0,0036	-0,0007	0,0029
75	187,500	15,9984	15,9993	-0,0099	-0,0043	0,0056
100	250,000	20,0005	-	0,0034	-	-

Results / Ergebnisse / Résultats :

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50	125,000	11,9994	11,9999	-0,0036	-0,0007	0,0029
75	187,500	15,9984	15,9993	-0,0099	-0,0043	0,0056
100	250,000	20,0005	-	0,0034	-	-

Summary of the results / Ergebniszusammenfassung / Conclusion sur les tests :

- The measures values are within the defined limits / Die gemessenen Werte liegen innerhalb der
mesure se trouvent dans les tolérances définies
- Compressive strength test passed / Druckfestigkeitsprüfung bestanden / Test on surpression cor
- The high voltage test is passed / Die Hochspannungsprüfung wurde bestanden / Le test de haut

Responsible for the tests / Verantwortlich für die Tests / Responsable des tests :
Department / Dienststelle / Département :
D | PA MF-H MI-PV PRO-1

Liste des tests :
//

Comments / Kommentare / Commentaires :

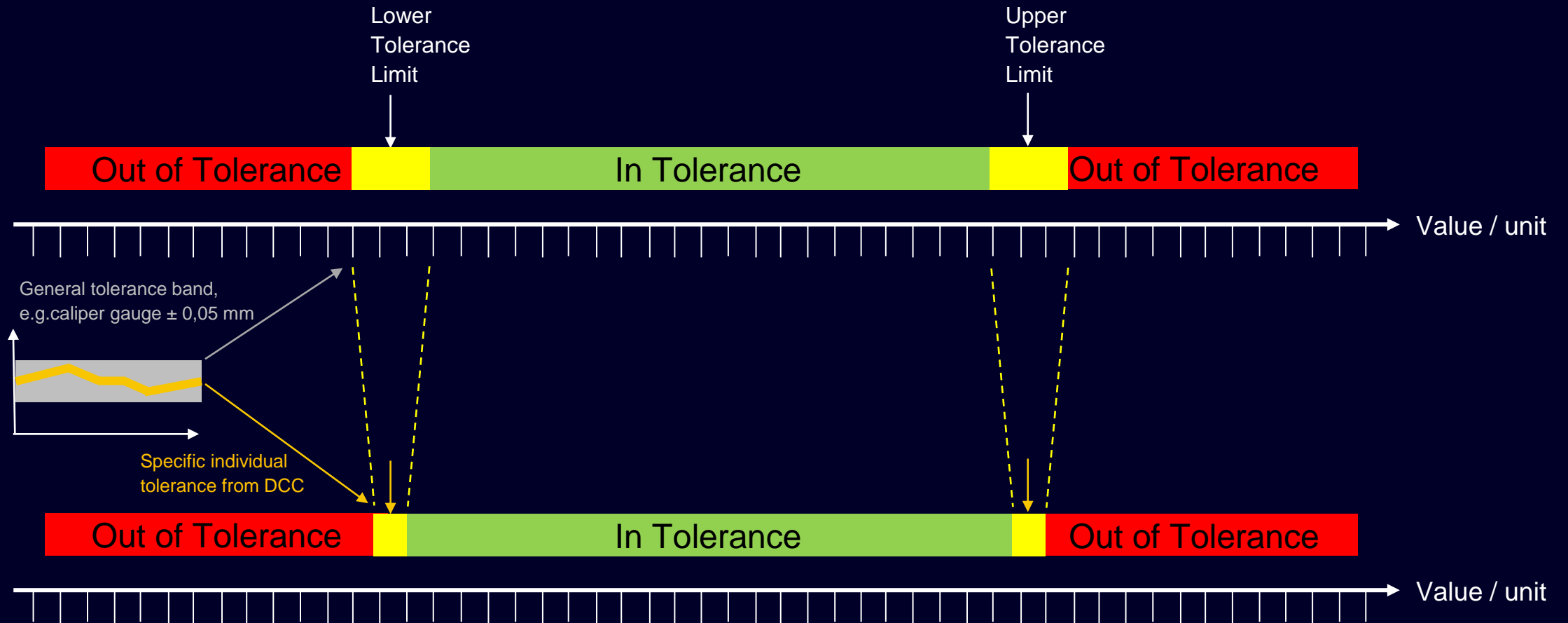
The supply / service described was inspected in accordance with the order and declared as true.
Die bezeichnete Lieferung / Leistung wurde entsprechend der Bestellung geprüft und für einwandfrei befunden.
La livraison / service ci-dessus a été, après vérification, déclaré conforme à la demande.

Department / Dienststelle / Département	Function / Funktion / Fonction	Name / Nom	Date
D PA MF-H MI-PV QM	Quality Manager Products PI-PV Qualitätsbeauftragter Produkte PI-PV Chargé de mission qualité Produits PI-PV		

Inherent Process and Customer Value:
Higher Repeatability and Reproducibility
by more precise process control at NO additional
cost → lower waste, higher yield

Benefits from Digital Calibration Certificate

DCC enables process yield in production processes



Precise and secure information about metrology system shrinks tolerance budgets !

The international digital System of Units: D-SI

A worldwide system of trading needs an internationally accepted system of units.

7 Base Units



<https://www.bipm.org/en/publications/si-brochure>

22 derived units

Name	Symbol	Quantity	Equivalents	SI base unit equivalents
hertz	Hz	frequency	1/s	s^{-1}
radian	rad	angle	m/m	1
steradian	sr	solid angle	m^2/m^2	1
new ton	N	force, w eight	$kg \cdot m/s^2$	$kg \cdot m \cdot s^{-2}$
pascal	Pa	pressure, stress	N/m^2	$kg \cdot m^{-1} \cdot s^{-2}$
joule	J	energy, w ork, heat	m·N, C·V, W·s	$kg \cdot m^2 \cdot s^{-2}$
w att	W	pow er, radiant flux	J/s, V·A	$kg \cdot m^2 \cdot s^{-3}$
coulomb	C	electric	s·A, F·V	s·A
volt	V	voltage, electrical	W/A, J/C	$kg \cdot m^2 \cdot s^{-3} \cdot A^{-1}$
farad	F	electrical capacitance	C/V, s/Q	$kg^{-1} \cdot m^{-2} \cdot s^4 \cdot A^2$
ohm	Ω	electrical	1/S, V/A	$kg \cdot m^2 \cdot s^{-3} \cdot A^{-2}$
siemens	S	electrical conductance	1/ Ω , A/V	$kg^{-1} \cdot m^{-2} \cdot s^3 \cdot A^2$
w eber	Wb	magnetic flux	J/A, T·m ² , V·s	$kg \cdot m^2 \cdot s^{-2} \cdot A^{-1}$
tesla	T	magnetic	V·s/m ² , Wb/m ²	$kg \cdot s^{-2} \cdot A^{-1}$
henry	H	electrical inductance	V·s/A, $\Omega \cdot s$, Wb/A	$kg \cdot m^2 \cdot s^{-2} \cdot A^{-2}$
degree Celsius	$^{\circ}C$	temperature relative	K	K
lumen	lm	luminous flux	cd·sr	cd
lux	lx	illuminance	lm/m^2	$cd \cdot m^{-2}$
becquerel	Bq	radioactivity (decays	1/s	s^{-1}
gray	Gy	absorbed	J/kg	$m^2 \cdot s^{-2}$
sievert	Sv	equivalent	J/kg	$m^2 \cdot s^{-2}$
katal	kat	catalytic activity	mol/s	$s^{-1} \cdot mol$

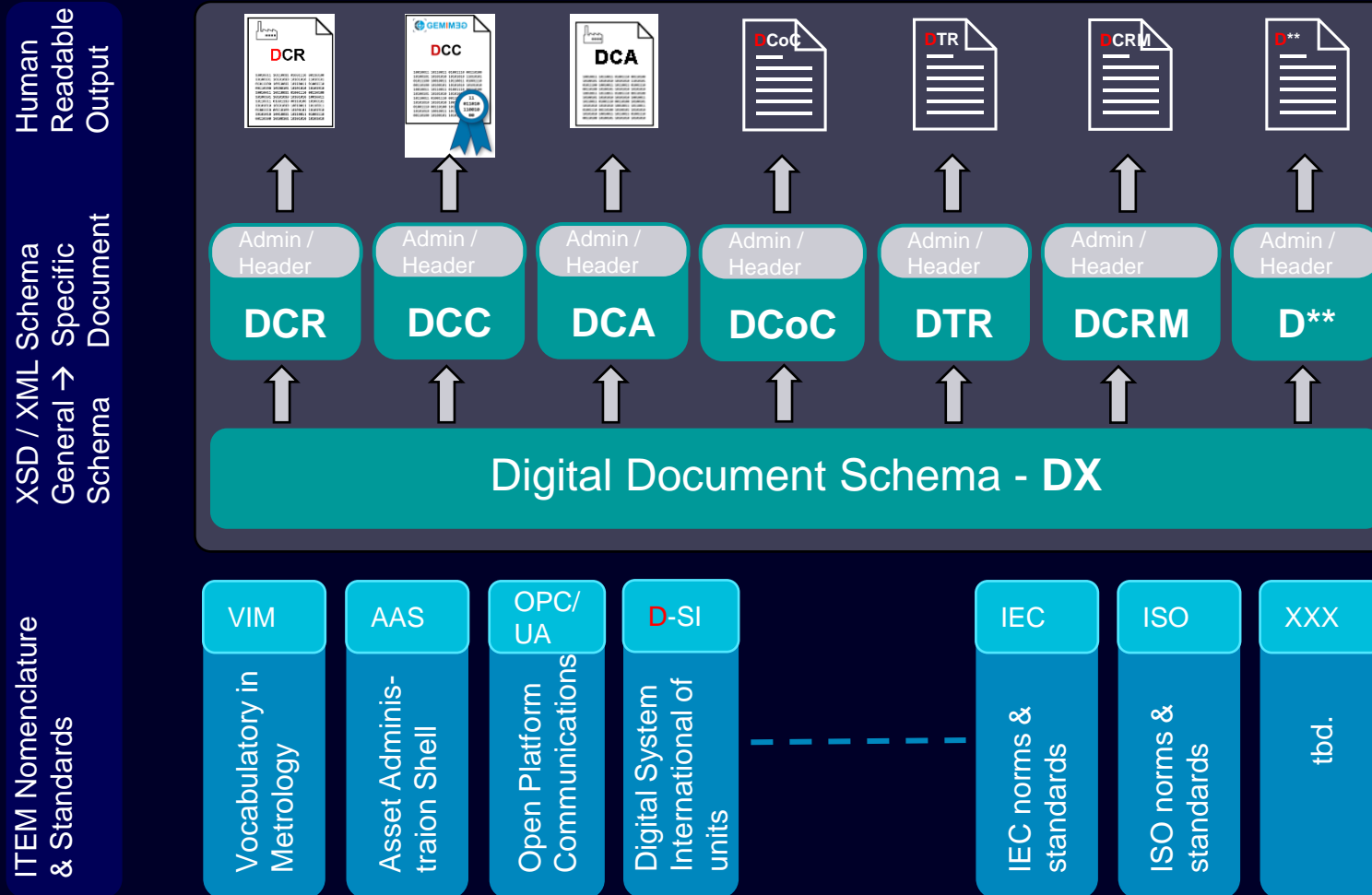
+ numerous „traditional“ units (mm Hg, bar, ...)
 + numerous imperial units (inch, pound, gallon, ...)

and their digital representation in an XML-structure:

```

<si:listUnit>\siemens</si:listUnit>
<si:listUnivariateUnc>
  <si:expandedUnc>
    <si:uncertainty>0.01</si:uncertainty>
    <si:coverageFactor>2</si:coverageFactor>
    <si:coverageProbability>0.95</si:coverageProbability>
    <si:distribution>normal</si:distribution>
  </si:expandedUnc>
</si:listUnivariateUnc>
<si:real>
  <si:value>113.5</si:value>
</si:real>
    
```


The Digital Calibration Document „Ecosystem“ A generic view...



Concept:

One common DX-Schema with Semantics
(as XSD / XML-Schema as parent schema)

Multiple different sub-schemata of DX as children / branches for

- DCR Digital Calibration Request
- DCC Digital Calibration Certificate ¹
- DCA Digital Calibration Answer
- DCoC Digital Certificate of Conformity ¹
- DTR Digital Test Report
- DCRM Digital Certificate for Reference Material ¹
- D** ... and many more digital documents ¹ governed by ISO 17xxx standards

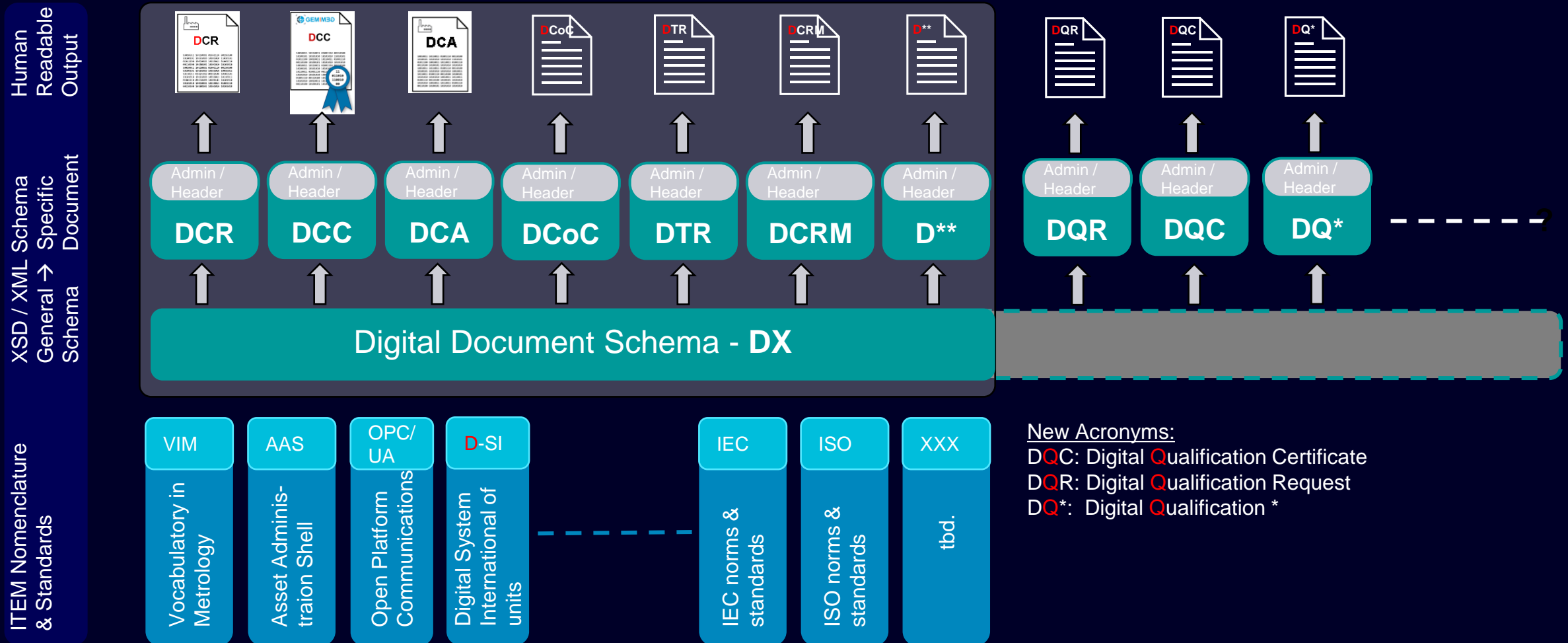
HRO: Multi-language available →
automatic conversion / generation from
(signed/qualified) D**.XML file

The Digital Calibration Document „Ecosystem“ A generic view...



Physical Sensors / „white box“ model sensors

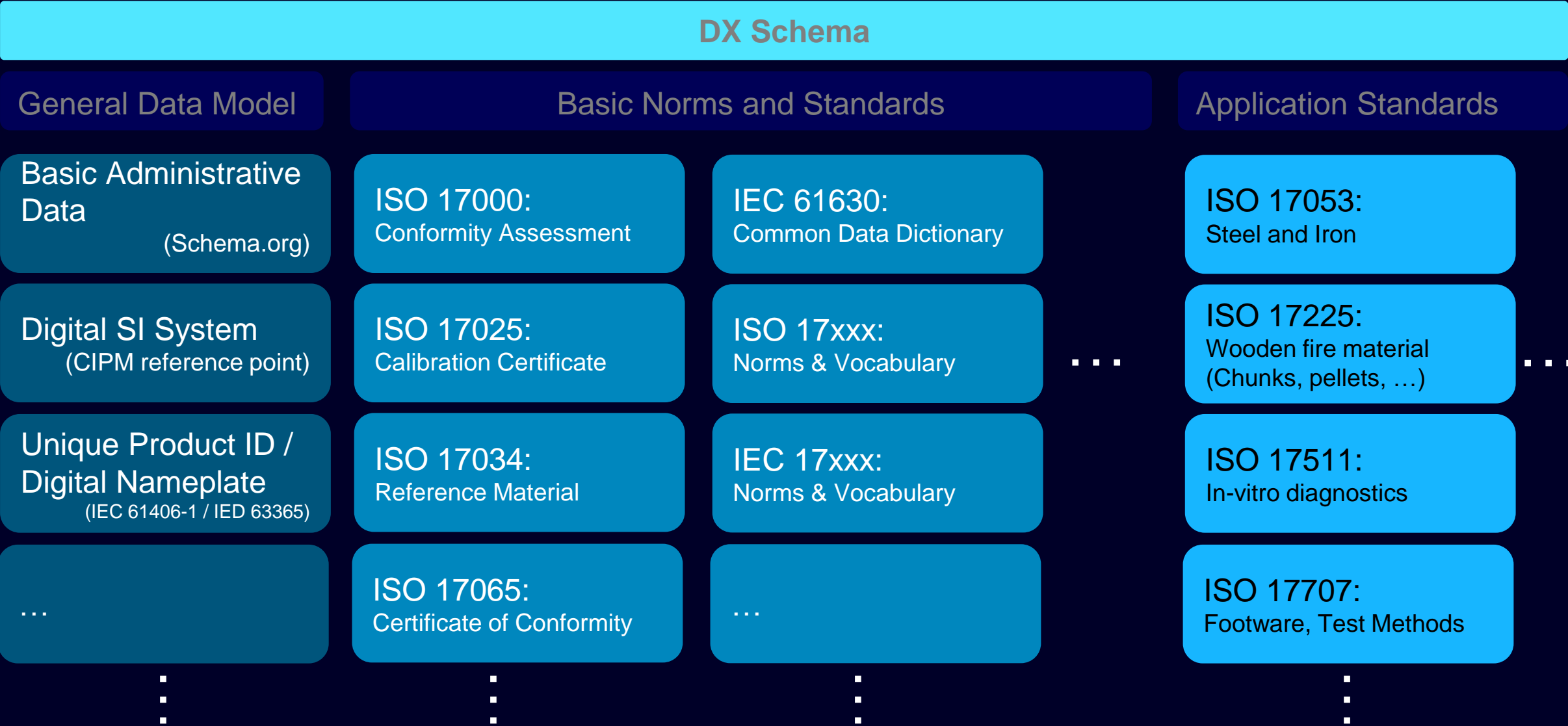
→ „black box“ model sensors / AI sensors



Building Blocks for a Digital Quality Document



Suggestion for modular structure of Semantic Model for DX-Schema



Asset Administration Shell

Submodel: Digital Quality Documents



```

AAS "DQD_submodelSample" [AssetAdministrationShell---54729C11] of [ NotApplicable]
├─ Asset AssetInformation
├─ SM <T> "dcc:digitalCalibrationCertificate" [https://example.com/ids/sm/8572_6002_5032_4058]
│   └─ SMC "dcc:administrativeData" (7 elements)
│       └─ SML "dcc:dccSoftware" (1 elements)
│           └─ SMC #00 "software" (5 elements)
│               └─ MLP "dcc:name" → notepad++ (32-bit)
│                   └─ SMC "dcc:name" (1 elements)
│                       └─ Prop "dcc:release" = 8.2
│                           └─ Prop "dcc:type" = application
│                               └─ SMC "dcc:description" (4 elements)
│                                   └─ SMC "dcc:coreData" (12 elements)
│                                       └─ SMC "dcc:items" (7 elements)
│                                           └─ SMC "dcc:calibrationLaboratory" (5 elements)
│                                               └─ SML "dcc:respPersons" (1 elements)
│                                                   └─ SMC "dcc:customer" (6 elements)
│                                                       └─ SML "dcc:statements" (1 elements)
│                                                           └─ SML "dcc:measurementResults" (1 elements)
│                                                               └─ SMC #00 "dcc:quantity" (8 elements)
│                                                                   └─ MLP "dcc:name" →
│                                                                       └─ SMC "dcc:description" (4 elements)
│                                                                           └─ SML "dcc:usedMethods" (1 elements)
│                                                                               └─ SML "dcc:usedSoftware" (1 elements)
│                                                                                   └─ SML "dcc:measuringEquipments" (1 elements)
│                                                                                       └─ SML "dcc:influenceConditions" (1 elements)
│                                                                                           └─ SML "dcc:measurementMetaData" (1 elements)
│                                                                                               └─ SML "dcc:results" (1 elements)
│                                                                                                   └─ SMC #00 <no idShort!> (3 elements)
│                                                                                                       └─ SML "dcc:comment" (1 elements)
│                                                                                                           └─ SMC "dcc:document" (5 elements)
│                                                                                                               └─ File "DCC" ⇒ /aasx/files/dcc_gp_temperature_simplified_v12.xml

```

Digital Quality Documents characterize the performance of a system / product over its entire life span via the following documents by recurring tests over time:

- Calibration (DCC)
- Conformity assessment (DCoC)
- Legal metrology (DCC, DCoC)
- Test reports (DTC)
- Acceptance tests
- Field Tests
- Check lists e.g. function / completeness

```

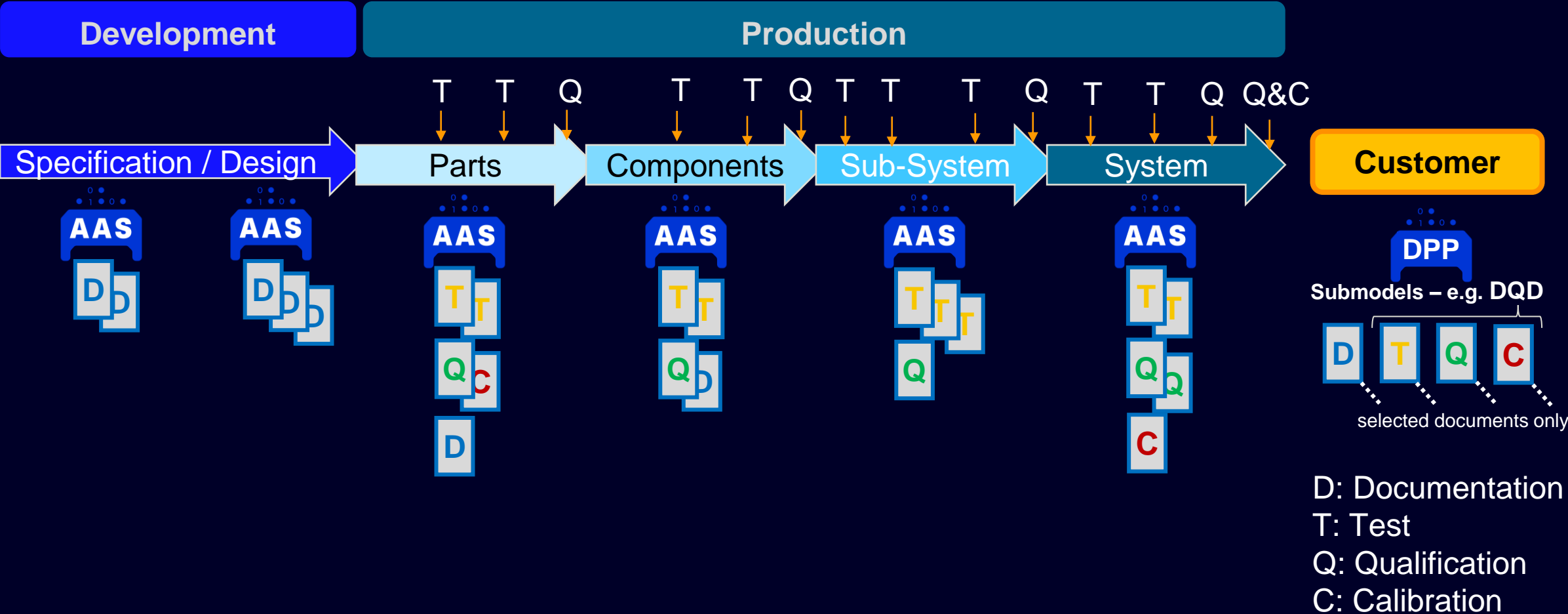
AAS "DQD_submodelSample" [AssetAdministrationShell---54729C11]
├─ SM <T> "digitalCalibrationCertificate" [https://example.com/ids/sm/8572_6002_5032_4058]
│   └─ SMC "dcc:administrativeData" (7 elements)
│       └─ SMC "dcc:measurementResults" (1 elements)
│           └─ Prop "dcc:comment" = example Comment
│               └─ SMC "dcc:document" (0 elements)
│                   └─ SMC "ds:Signature" (3 elements)

```

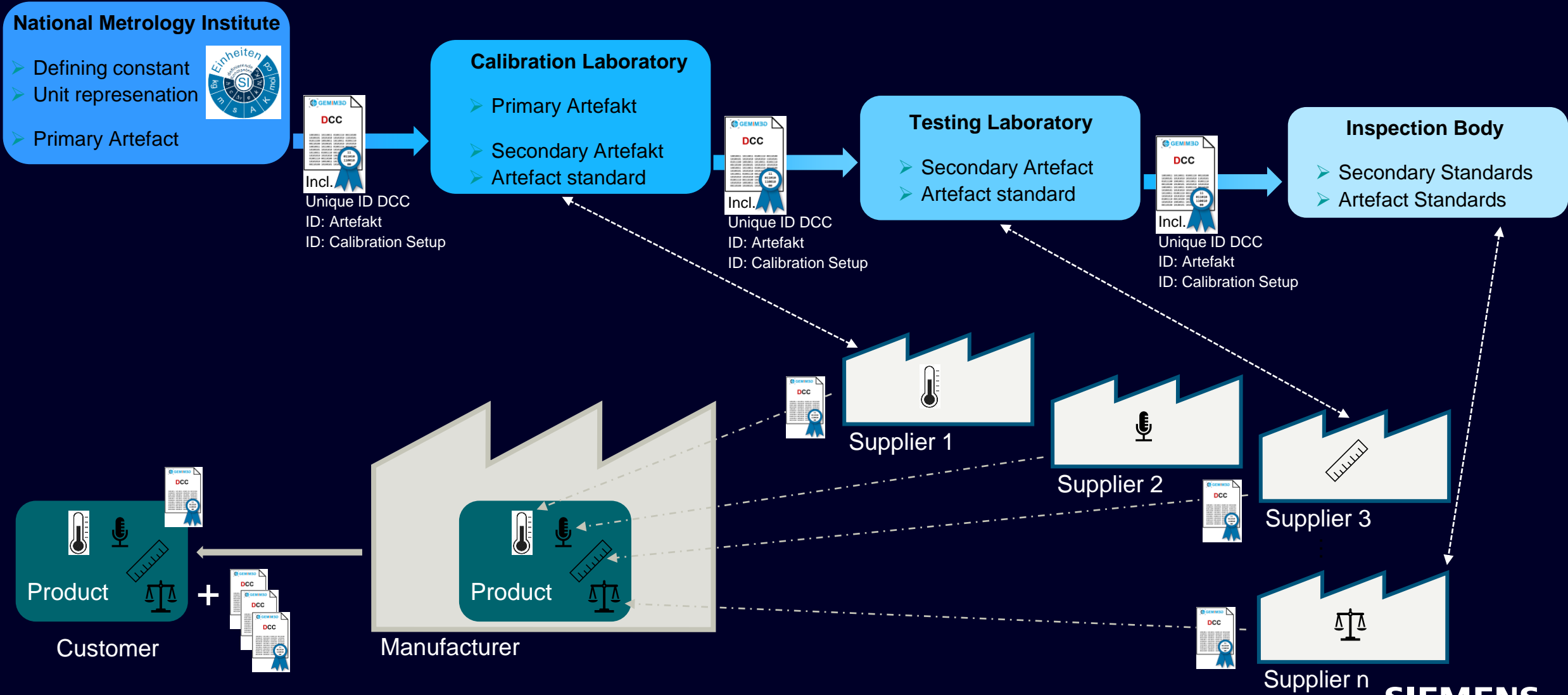
➔ Signed document for Originality and Authenticity

Product Lifecycle from Cradle to Gate for Digital Quality Documents

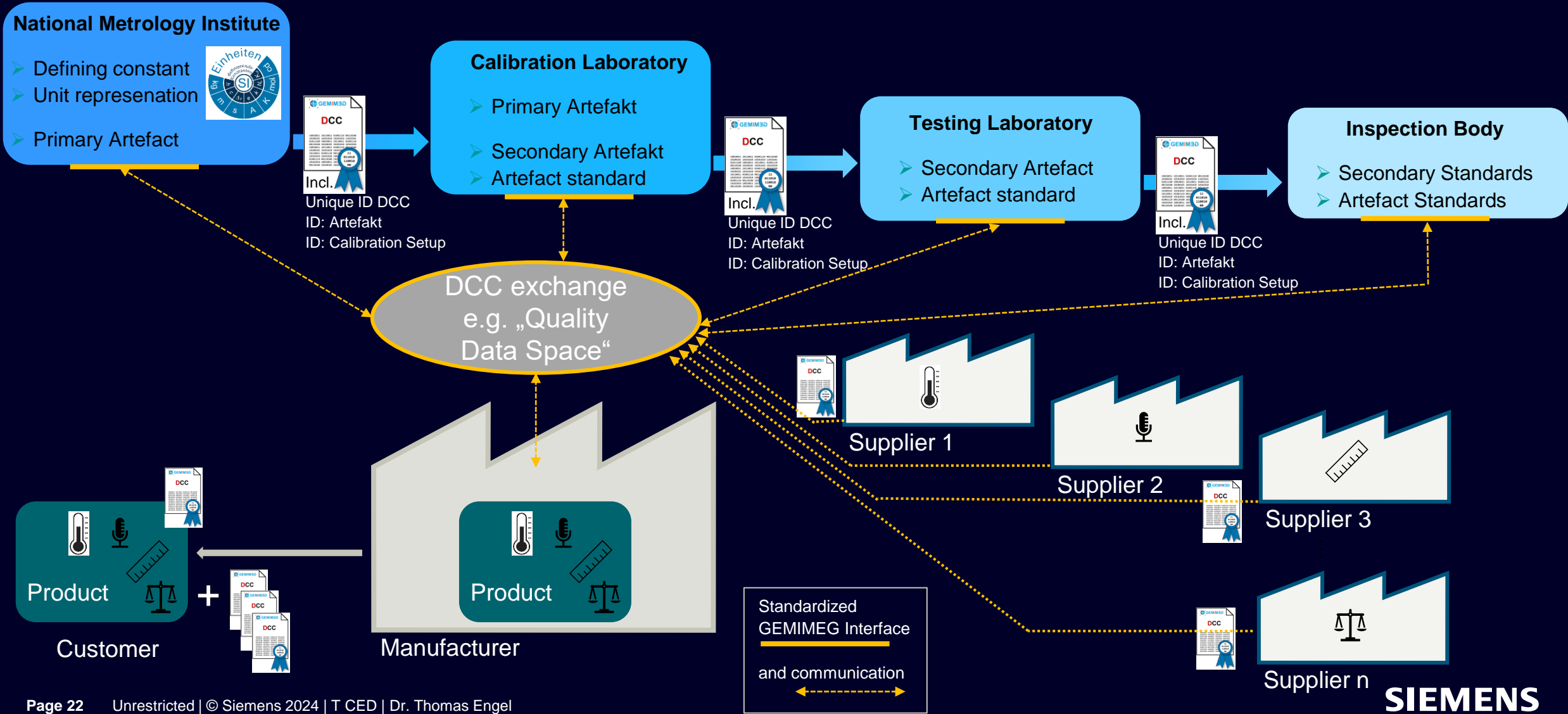
AAS - DPP - DQD



Usecase: System Integration of industrial products and industrial production systems



Usecase: System Integration of industrial products and industrial production systems



Digitize, Digitalisation and Digital Transformation

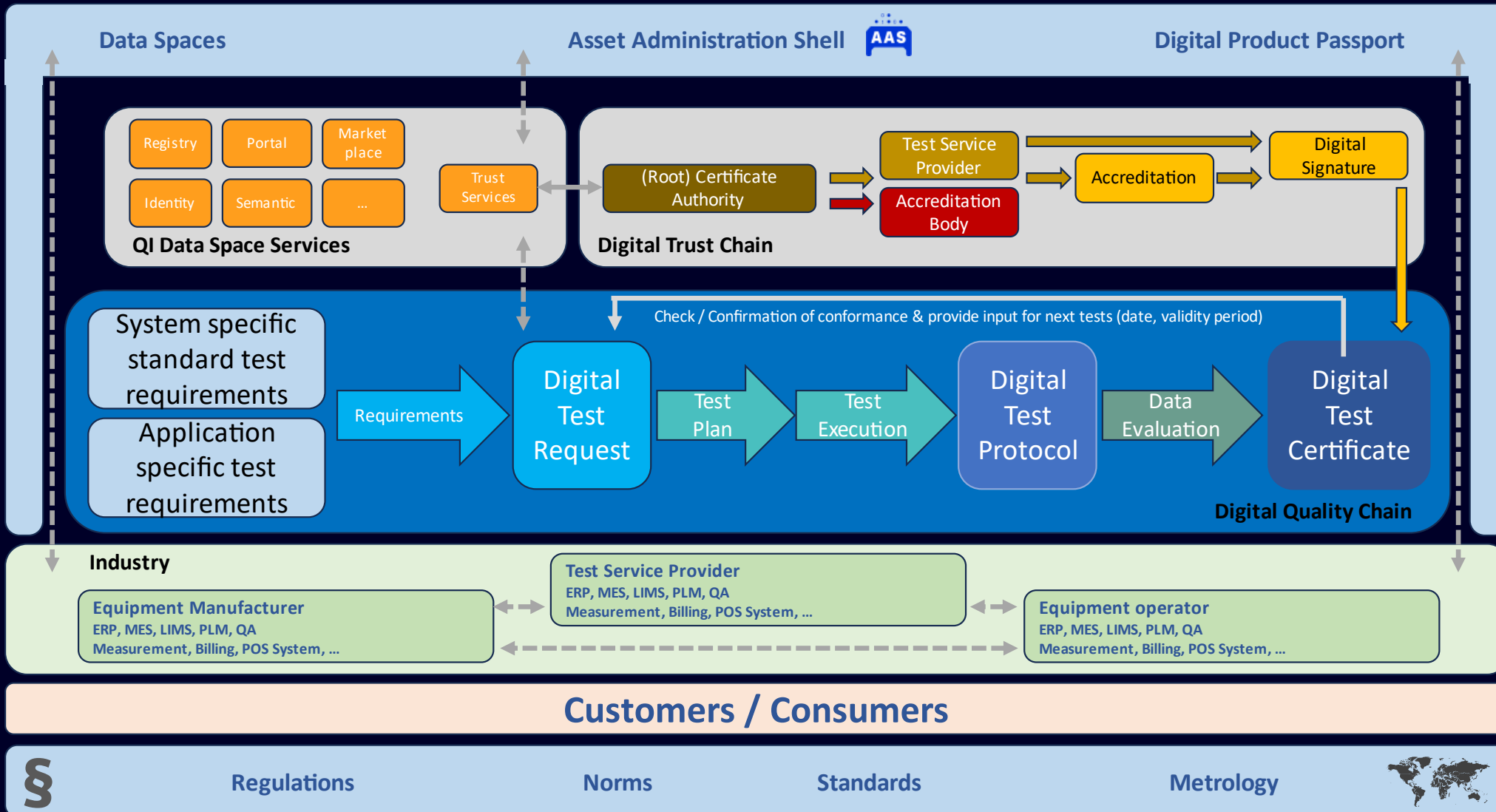
Digital Transformation:

- New business opportunities – cost structure
 - Lower waste / higher first pass yield
 - Higher precision with larger tolerances
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- Business transformation from „economy of conformity“ to „economy of consistency“



Foto: Alexander Hafemann; Mlenny/iStockphoto.com

The Future: GEMIMEG-X ? (Project proposal submitted to BMWK, under evaluation)



Summary: Benefits from DCC in a Stakeholder perspective

Sensor owner

Asset Administration

- Full Automation
- Correct Data
- Full Traceability

DCR standardize calibration requirements

Consistency in DCC information content

Calibration Tracking

- Due date
- Intervals
- Performance

Resilience

Calibration Service

Standard calibration requirements in DCR

- Data Handling
- Administrative Data
- Order Clarification

DCC based on DCR
* DCR is „DCC template“

Full process automation

Secure data provisioning in platform / data space: DCR / DCC / revocation

Industry 4.0 compliant

New digital Businesses

Sensor User

Full process automation

- Instant data availability
- Reduced error margin
- Accurate data improve process yield

Consistent DCC data

- Across calibration service providers

Secure data availability in platform / data space: DCR / DCC / revocation

Sensor data lifetime / type evaluation – recal. interval

Industry 4.0 compliant

Legal / Regulatory

Full data traceability

- **Instant & long term data availability**
- DCR / DCC / DCA
- Calibration laboratory accreditation
- Transparent process quality chain with all stakeholders in a quality process

Automated (Pre-)Auditing

- Secure data availability in platform / data space:
- DCR / DCC / revocation
 - Independent audit trail

The value behind the GEMIMEG concept for industrial processes

CUSTOMER VALUE

- Efficient Processes – FAIR data
- Autonomy Gain – Resilience
- Standardized – Interoperability
- Yield Improvement – Return of Invest

PROCESS VALUE

- Secure Interoperability & Traceability
- Automated (&) Auditable Workflows
- Failsafe & Instant Data Availability
- Excellent & Compliant Processes

→ Sustainable, circular processes!

Contact

Published by Siemens AG

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More content:

GEMIMEG-II — How metrology can go digital...

<https://iopscience.iop.org/article/10.1088/1361-6501/ace468/meta>

PyDCC

<https://github.com/siemens/pydcc/>

Contributions to previous international DCC conferences

Presentation and paper @ IMEKO 2024 end of August